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Melting and Polymorphism of Indium Antimonide at High Pressures*

The change of electrical resistivity with pressure of indium antimonide has been studied by Keyes¹ up to 12,000 atmospheres and recently by Gebbie *et al.*; who extended measurements to 70,000 atmospheres. The resistivity measured at room temperature, according to them, shows an initial increase with pressure and drops several orders of magnitude at 30,000 atmospheres. This sharp drop in resistance was attributed by Gebbie *et al.* to melting, with the indium antimonide changing from a state of semiconduction in the crystal to metallic conduction in the liquid phase. A melting curve, based on the pressures giving a drop in resistivity at temperatures of 150°-800° K., was presented by them. The plotted points exhibit a wide scatter and the authors mention that the latent heat of melting calculated from the melting curve slope, namely 27 cal./gm., compares unfavorably with the experimentally determined value of 47.2 cal./gm. Hence it appeared to us that the melting curve of indium antimonide should be investigated again.

A piston-cylinder apparatus was used for generating high pressures. In this device, a tungsten carbide chamber 0.5 in. in diameter and 2 in. long. The sample was sealed in a length of platinum tubing, $\frac{1}{8}$ in. \times $\frac{1}{8}$ in., which was placed inside the talc-sheathed graphite furnace, which serves both for heating the sample and transmitting pressure to it. The absorption of latent heat accompanying melting was detected by differential thermal analysis. The sample temperature and the differential temperature were recorded simultaneously on a strip-chart recorder. The record of differential temperature analysis shows the latent heat accompanying melting as a break in the slope, or reversal of trend. Thus the melting point can be determined accurately. The high-pressure apparatus and the experimental techniques have been described in detail by Kennedy and Newton.² Semiconductor grade polycrystalline indium antimonide supplied by the Indium Corporation of America was used. Kennedy and Newton used platinum containers for the melting-point determination of both indium and antimony and have found platinum an inert container for both metals.

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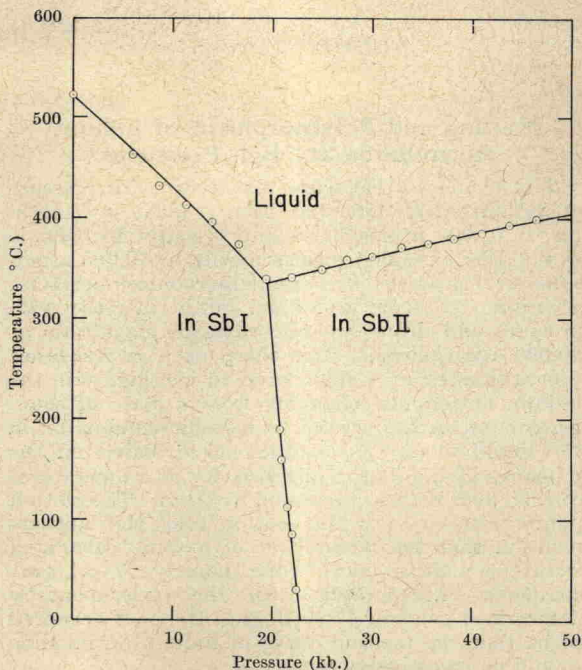


Fig. 1. Phase diagram of indium antimonide

Volume-change of transition was used to locate the lowest five points of Fig. 1, because of the small heat of transition and the advantage in accuracy in intersecting a phase-boundary at a high angle. Powdered indium antimonide was intimately mixed with silver chloride and the mix was compressed into a pellet of the shape and dimensions needed to fill the high-pressure chamber. A heating tape was wound on the steel supporting-ring of the 'Carboloy' core. In this way, a temperature of nearly 200° C. at the sample site could be reached. Ram pressure and piston displacement were recorded on an x - y recorder. Piston friction was eliminated by a piston rotation method⁴ and wall-friction was reduced by a 0.001 in. lead-foil wrapping. A change of state is revealed by a break in the pressure versus displacement curve.

Fig. 1 shows the melting curve of indium antimonide obtained in the present investigation. It will be seen that the melting point goes down until a pressure of 19.4 kb. is reached and rises thereafter with increasing pressure. By inserting the initial value of the slope of this melting curve in the Clausius-Clapeyron equation and using the known volume contraction on melting ($\Delta V/V_{\text{solid}} = 0.13$), the latent